

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination HASHIMURA ET AL.	
		Examiner Deborah Yee	Art Unit 1742	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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	N	2000-160284	06-2000	Japan	Uno, Mitsuo et al.	-----
	O	02047240	02-1990	Japan	Ochi Tatsuro	-----
	P					
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NON-PATENT DOCUMENTS

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